

INFORMATION DISCLOSURE STATEMENT

Applicant	:	Stelzle, et al.
App. No.	:	Unknown
Filed	:	October 16, 2003
For	:	PAIR OF MEASURING ELECTRODES, BIOSENSOR COMPRISING A PAIR OF MEASURING ELECTRODES OF THIS TYPE, AND PRODUCTION PROCESS
Examiner	:	Unknown
Group Art Unit	:	Unknown

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Enclosed is form PTO-1449 listing four (4) references that are also enclosed.

This Information Disclosure Statement is being filed upon the filing date of this application and no fee is required in accordance with 37 C.F.R. § 1.97(b)(1).

Respectfully submitted,
KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: 10/16/03

By: _____
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Registration No. 34,303
Attorney of Record
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FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)	ATTY. DOCKET NO. WWELL78.006C1	APPLICATION NO. Unknown
	APPLICANT Stelzie	
	FILING DATE October 16, 2003	GROUP Unknown

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	1.	WO 00/62047	10/19/2000	PCT				X

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)	
	2.	Musil, et al., NANOSTRUCTURING OF GOLD ELECTRODES FOR IMMUNOSENSING APPLICATIONS, <i>Journal of Vacuum Science and Technology</i> , American Institute of Physics, New York, NY; Bd. 13, No. 6; Nov./Dec. 1995; pp. 2781-2786
	3.	Nagale, et al., INDIVIDUALLY ADDRESSABLE, SUBMICROMETER BAND ELECTRODE ARRAYS. 1. FABRICATION FROM MULTILAYERED MATERIALS, <i>Analytical Chemistry</i> , American Chemical Society, Columbus, US; Bd. 70, No. 14, July 15, 1998; pp. 2902-2907
	4.	Niwa, et al., HIGHLY SENSITIVE AND SELECTIVE VOLTAMMETRIC DETECTION OF DOPAMINE WITH VERTICALLY SEPARATED INTERDIGITATED ARRAY ELECTRODES, <i>Electroanalysis</i> , VHC Publishers, Inc., U.S.; Bd. 3; 1991; pp. 163-168

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EXAMINER	DATE CONSIDERED
*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.	